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## 2 Detection of critical hazards in digital MOS VLSI circuits by switch-level timing simulation

Sass, D.; Warmers, H.; Horneber, E.-H.; Circuits and Systems, 1990., Proceedings of the 33rd Midwest Symposium on , 12-14 Aug. 1990

Page(s): 584 -587 vol.1

## [Abstract] [PDF Full-Text (228 KB)] IEEE CNF

3 Switch-level timing models in the MOS simulator BRASIL

Warmers, H.; Sass, D.; Horneber, E.-H.;

Design Automation Conference, 1990. EDAC. Proceedings of the European , 12-15 March 1990

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A. Papanikolaou, M. Miranda, F. Catthoor, H. Corporaal, H. De Man, D. De Roest, M. Stucchi, Karen Maex

**Proceedings of the 2003 international workshop on System-level interconnect prediction** April 2003

In this paper we show how to exploit energy-delay trade-offs that exist due to the variation of the technology parameters for the implementation of interconnect wires. We also evaluate how these trade-offs can be propagated to the memory module level, so we can minimise the power consumption of the entire memory organisation (i.e., memories and connections between them). Our approach is that at future technology nodes the delay problem can be handled at the application level, so given any delay ...

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The proliferation of mobile and pervasive computing devices has brought energy constraints into the limelight. Energy-conscious design is important at all levels of system architecture, and the software has a key role to play in conserving battery energy on these devices. With the increasing popularity of spatial database applications, and their anticipated deployment on mobile devices (such as road atlases and GPS-based applications), it is critical to examine the energy implications of spatial ...

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David E. Lackey, Paul S. Zuchowski, Juergen Koehl

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5 JouleTrack: a web based tool for software energy profiling

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Amit Sinha, Anantha P. Chandrakasan

## Proceedings of the 38th conference on Design automation June 2001

A software energy estimation methodology is presented that avoids explicit characterization of instruction energy consumption and pre-dicts energy consumption to within 3% accuracy for a set of bench-mark programs evaluated on the StrongARM SA-1100 and Hitachi SH-4 microprocessors. The tool, JouleTrack, is available as an online resource and has various estimation levels. It also isolates the switch-ing and leakage components of the energy consumption.

6 Preservation of passivity during RLC network reduction via split congruence transformations

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